

Application Serial No. 10/773,524
Response to Office Action

Customer No. 01933

Attorney Docket No. 04083/LH

This paper is being submitted
via EFS-Web on October 11, 2007

**IN THE UNITED STATES PATENT
AND TRADEMARK OFFICE**

Applicant(s): Takashi YONEYAMA, et al.

Serial No. : 10/773,524

Confirm. No.: 7190

Filed : February 6, 2004

For : DEFECT INSPECTION APPARATUS AND
DEFECT INSPECTION METHOD

Art Unit : 2609

Examiner : Tsung Yin Tsai

In the event that this Paper is late filed, and the necessary petition for extension of time is not filed concurrently herewith, please consider this as a Petition for the requisite extension of time, and to the extent not already paid, authorization to charge the extension fee to Account No. 06-1378. In addition, authorization is hereby given to charge any fees for which payment has not been submitted, or to credit any overpayments, to Account No. 06-1378.

A M E N D M E N T

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

S I R :

This is responsive to the Office Action mailed May 11, 2007 the extended term for response to which expires on October 11, 2007.

Amendments to the Specification begin on page 2 of this paper.

Amendments to the Claims are set forth in the listing of claims which begins on page 4 of this paper. Claims 1, 5, 6, 8 and 13-17 are canceled; claims 2, 3, 7 and 9-11 are amended; claims 18-26 are added; and claims 4 and 12 are maintained.

Remarks begin on page 13 of this paper.